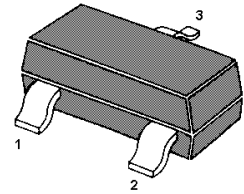
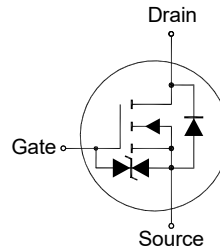


MMFTN138K-AH

N-Channel Enhancement Mode MOSFET

Features

- AEC-Q101 Qualified
- Advanced trench cell design
- High speed switch
- Halogen and Antimony Free(HAF), RoHS compliant
- ESD protected
- Typical ESD Protection HBM Class 1C



1. Gate 2. Source 3. Drain
TO-236 Plastic Package

Classification	Voltage Range(V)
0A	< 125
0B	125 to < 250
1A	250 to < 500
1B	500 to < 1000
1C	1000 to < 2000
2	2000 to < 4000
3A	4000 to < 8000
3B	≥ 8000

Applications

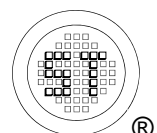
- Portable appliances
- Load switch appliances

Absolute Maximum Ratings ($T_a = 25\text{ }^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current ¹⁾ at $V_{GS} = 10\text{ V}$, $T_a = 25\text{ }^{\circ}\text{C}$ at $V_{GS} = 10\text{ V}$, $T_a = 100\text{ }^{\circ}\text{C}$	I_D	360 230	mA
Peak Drain Current , Pulsed($t_p < 10\text{ }\mu\text{S}$)	I_{DM}	1.2	A
Total Power Dissipation	P_{tot}	350 ²⁾ 420 ¹⁾	mW
Thermal Resistance from Junction to Ambient	$R_{\theta JA}$	370 ²⁾ 300 ¹⁾	$^{\circ}\text{C/W}$
Operating Junction Temperature	T_j	- 55 to + 150	$^{\circ}\text{C}$
Storage Temperature Range	T_{stg}	- 55 to + 150	$^{\circ}\text{C}$

¹⁾ Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm².

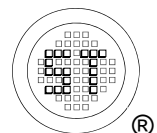
²⁾ Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.



MMFTN138K-AH

Characteristics at $T_a = 25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit
STATIC PARAMETERS					
Drain-Source Breakdown Voltage at $I_D = 250\ \mu\text{A}$	$V_{(BR)DSS}$	60	-	-	V
Gate-Source Threshold Voltage at $V_{GS} = V_{DS}$, $I_D = 250\ \mu\text{A}$	V_{GSth}	0.48	-	1.6	V
Drain-Source Leakage Current at $V_{DS} = 60\ \text{V}$	I_{DSS}	-	-	1	μA
Gate-Source Leakage Current at $V_{GS} = \pm 20\ \text{V}$ at $V_{GS} = \pm 10\ \text{V}$	I_{GSS}	- -	- -	10 1	μA
Drain-Source On-State Resistance at $V_{GS} = 10\ \text{V}$, $I_D = 350\ \text{mA}$ at $V_{GS} = 4.5\ \text{V}$, $I_D = 200\ \text{mA}$ at $V_{GS} = 2.5\ \text{V}$, $I_D = 10\ \text{mA}$	$R_{DS(ON)}$	- - -	- - -	1.6 2.2 6.5	Ω
DYNAMIC PARAMETERS					
Forward Transconductance at $V_{DS} = 5\ \text{V}$, $I_D = 400\ \text{mA}$	g_{FS}	-	755	-	mS
Gate Resistance at $V_{DS} = 0\ \text{V}$, $V_{GS} = 0\ \text{V}$, $f = 1\ \text{MHz}$	R_g	-	38	-	Ω
Input Capacitance at $V_{DS} = 10\ \text{V}$, $f = 1\ \text{MHz}$	C_{iss}	-	51.3	-	pF
Output Capacitance at $V_{DS} = 10\ \text{V}$, $f = 1\ \text{MHz}$	C_{oss}	-	11.6	-	pF
Reverse Transfer Capacitance at $V_{DS} = 10\ \text{V}$, $f = 1\ \text{MHz}$	C_{rss}	-	8.2	-	pF
Gate charge total at $V_{DS} = 25\ \text{V}$, $I_D = 1\ \text{A}$, $V_{GS} = 10\ \text{V}$ at $V_{DS} = 25\ \text{V}$, $I_D = 1\ \text{A}$, $V_{GS} = 4.5\ \text{V}$	Q_g	- -	1.3 0.85	- -	nC
Gate to Source Gate Charge at $V_{DS} = 25\ \text{V}$, $I_D = 1\ \text{A}$, $V_{GS} = 10\ \text{V}$	Q_{gs}	-	0.45	-	nC
Gate to Drain Charge at $V_{DS} = 25\ \text{V}$, $I_D = 1\ \text{A}$, $V_{GS} = 10\ \text{V}$	Q_{gd}	-	0.3	-	nC
Turn-On Delay Time at $V_{DS} = 10\ \text{V}$, $V_{GS} = 4.5\ \text{V}$, $I_D = 1\ \text{A}$, $R_G = 51\ \Omega$	$t_{d(on)}$	-	13.4	-	ns
Turn-On Rise Time at $V_{DS} = 10\ \text{V}$, $V_{GS} = 4.5\ \text{V}$, $I_D = 1\ \text{A}$, $R_G = 51\ \Omega$	t_r	-	13.3	-	ns
Turn-Off Delay Time at $V_{DS} = 10\ \text{V}$, $V_{GS} = 4.5\ \text{V}$, $I_D = 1\ \text{A}$, $R_G = 51\ \Omega$	$t_{d(off)}$	-	7.8	-	ns
Turn-Off Fall Time at $V_{DS} = 10\ \text{V}$, $V_{GS} = 4.5\ \text{V}$, $I_D = 1\ \text{A}$, $R_G = 51\ \Omega$	t_f	-	4.6	-	ns
Body-Diode PARAMETERS					
Drain-Source Diode Forward Voltage at $I_S = 300\ \text{mA}$	V_{SD}	0.47	-	1.2	V
Body Diode Reverse Recovery Time at $I_S = 1\ \text{A}$, $di/dt = 100\ \text{A} / \mu\text{s}$	t_{rr}	-	9.2	-	ns
Body Diode Reverse Recovery Charge at $I_S = 1\ \text{A}$, $di/dt = 100\ \text{A} / \mu\text{s}$	Q_{rr}	-	3.7	-	nC



Electrical Characteristics Curves

Fig. 1 Typical Output Characteristic

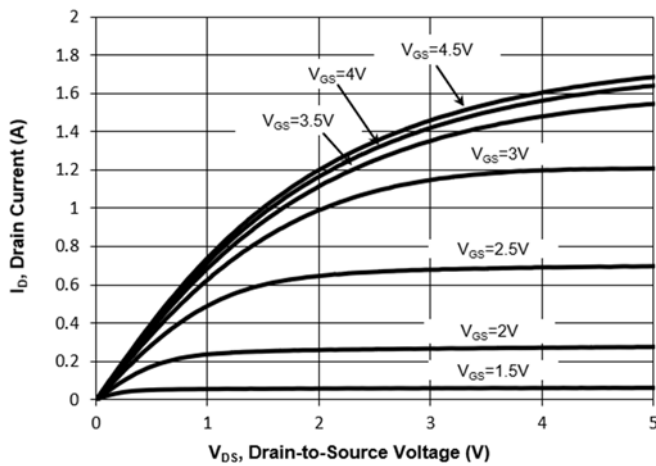


Fig. 2 Typical Transfer Characteristic

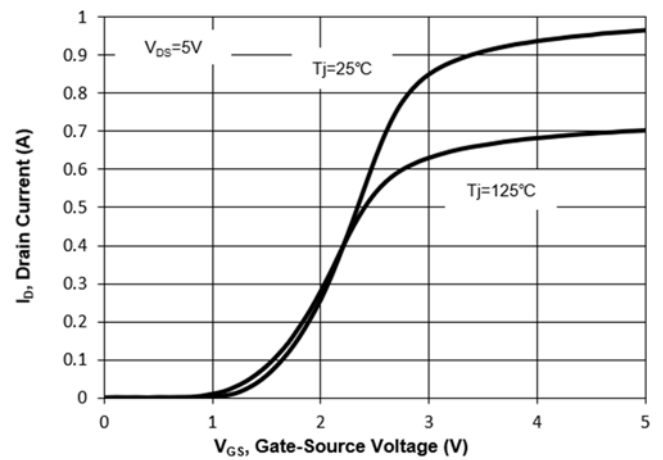


Fig. 3 on-Resistance vs Drain Current

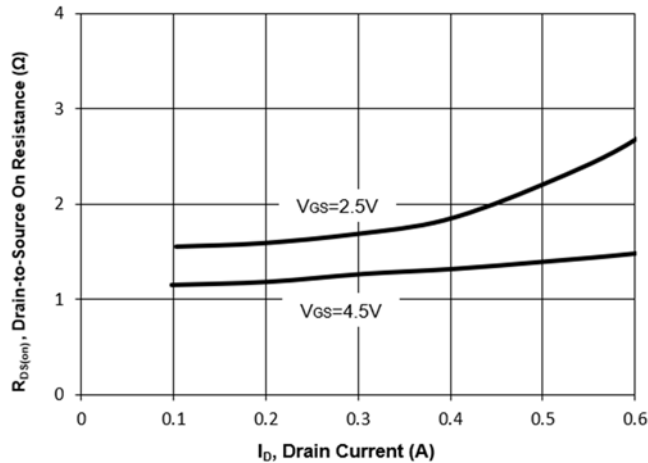


Fig. 4 on-Resistance vs. Gate Voltage

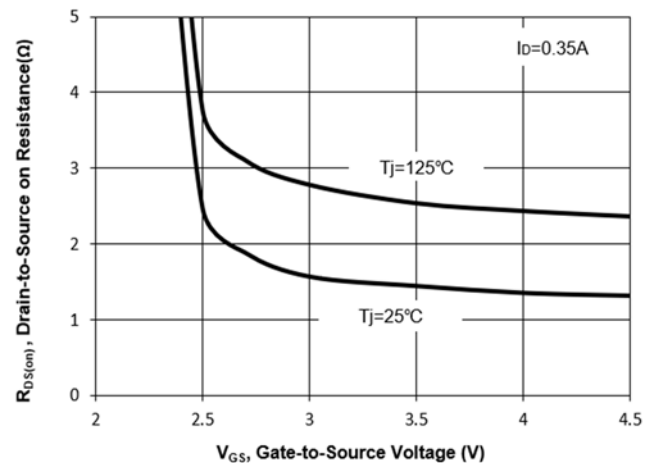


Fig. 5 on-Resistance vs. T_J

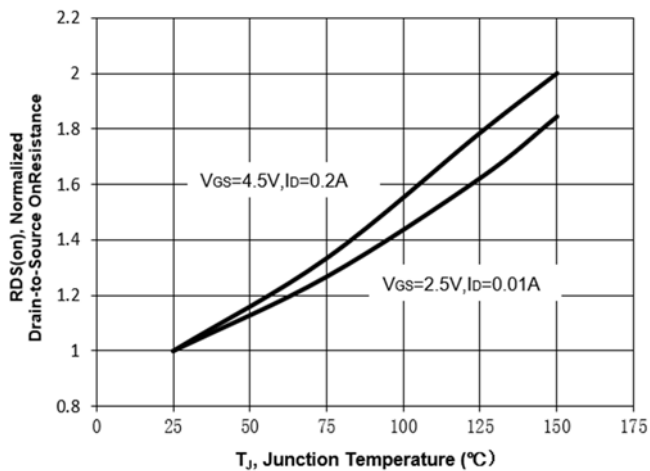
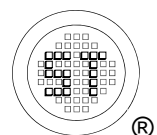
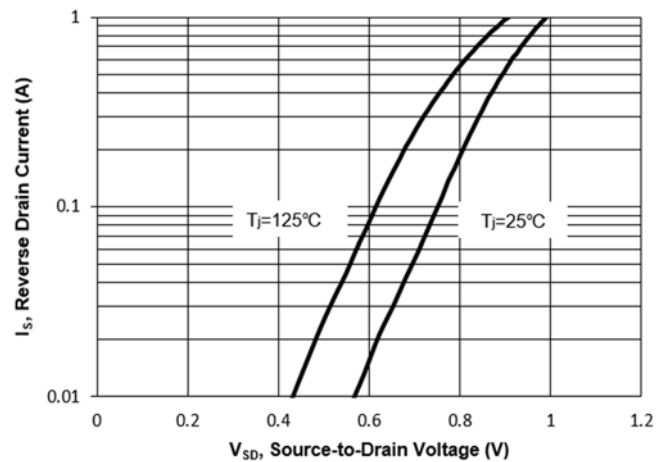


Fig. 6 Typical Forward Characteristic



Electrical Characteristics Curves

Fig. 7 Typical Junction Capacitance

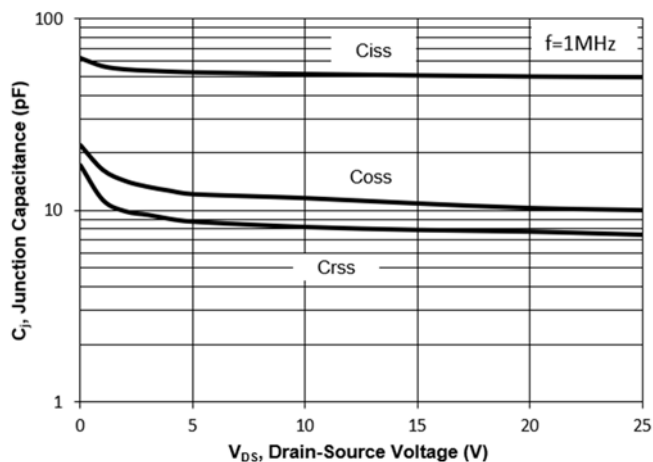


Fig. 8 $V_{(BR)DSS}$ vs. Junction Temperature

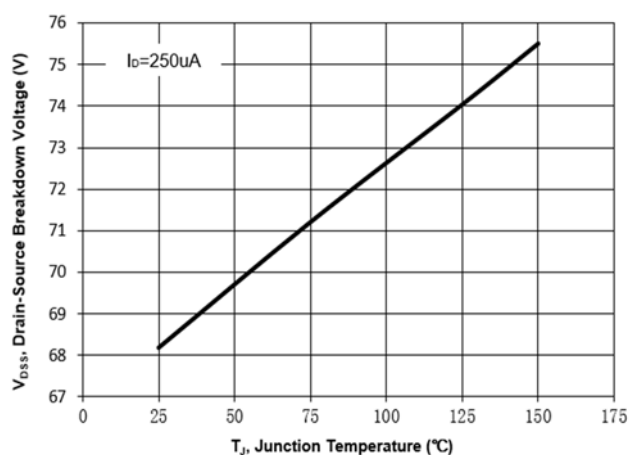


Fig. 9 Gate Threshold Variation vs. T_j

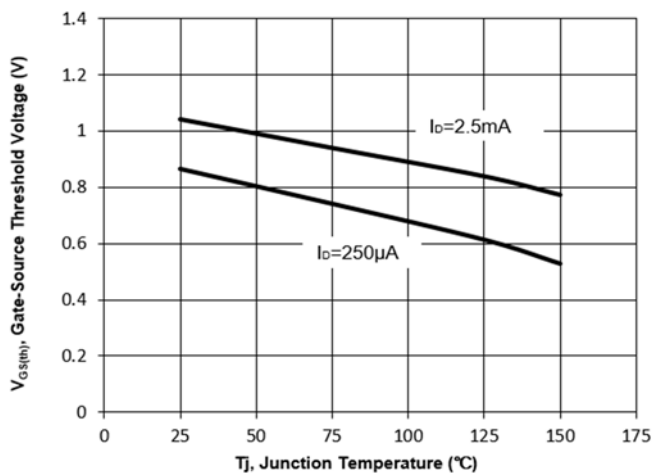
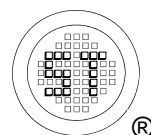
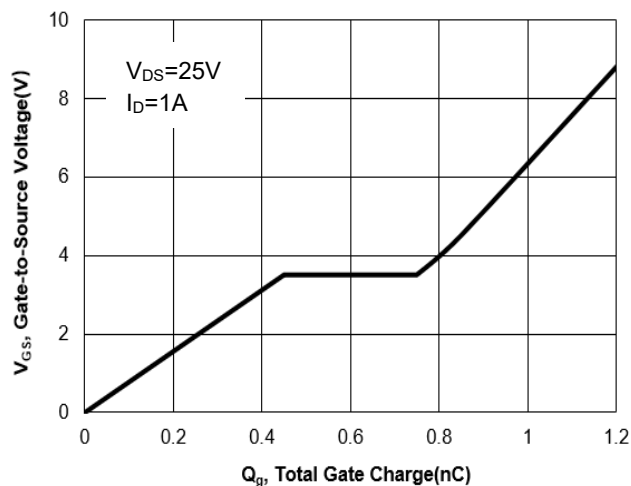


Fig. 10 Gate Charge



Test Circuits

Fig.1-1 Switching times test circuit

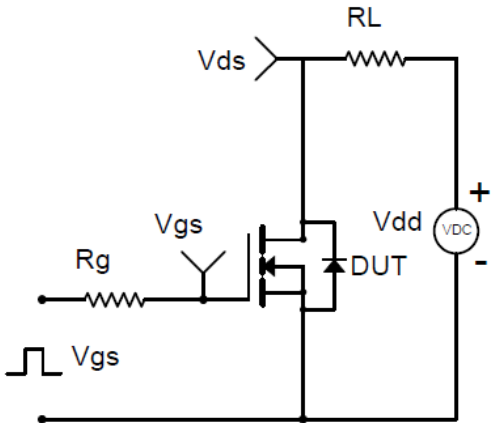


Fig.1-2 Switching Waveform

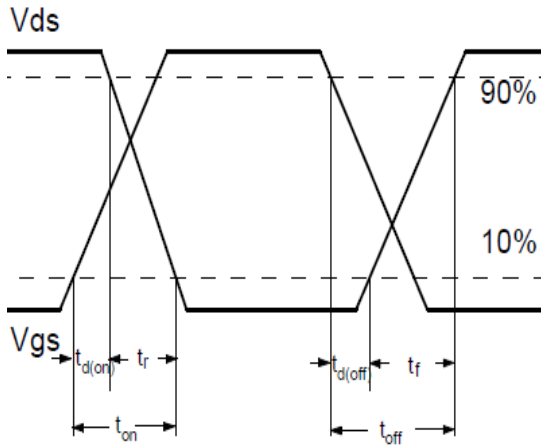


Fig.2-1 Gate charge test circuit

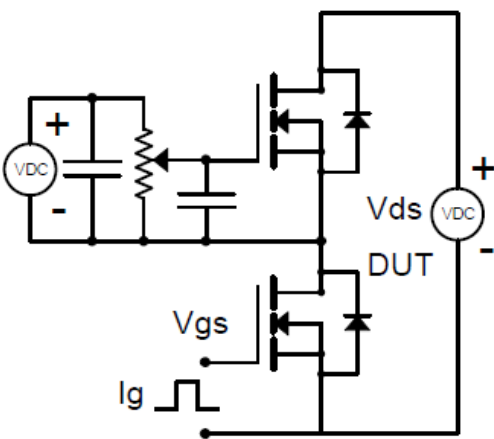
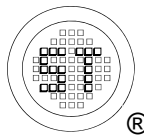
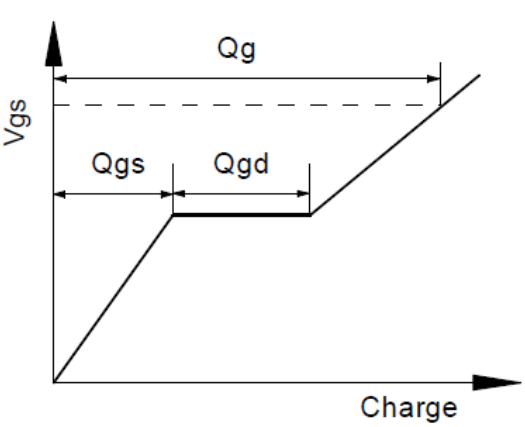


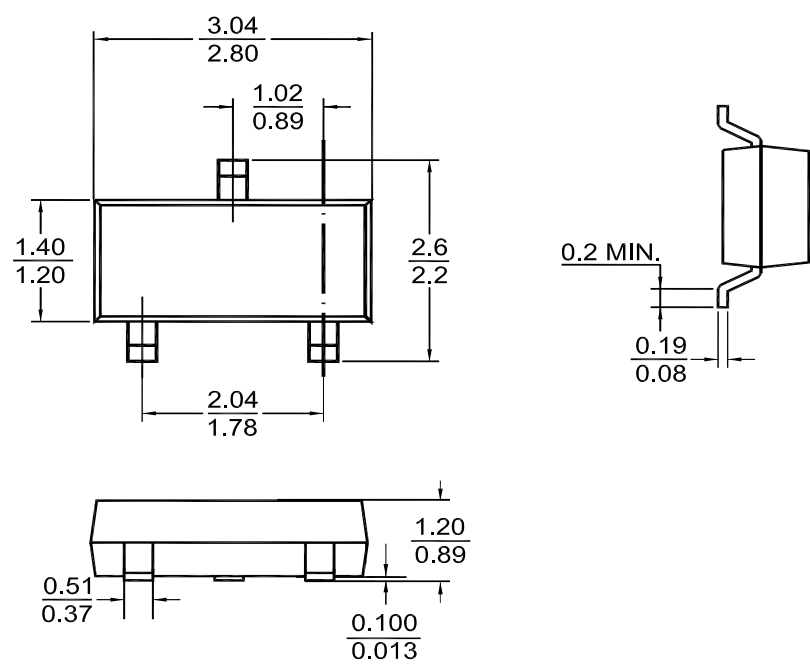
Fig.2-2 Gate charge waveform



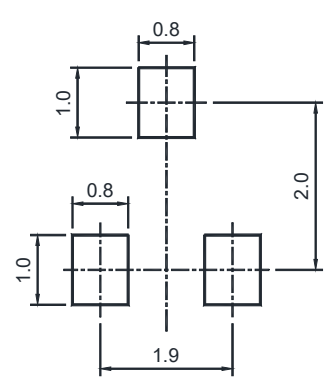
MMFTN138K-AH

Package Outline (Dimensions in mm)

TO-236



Recommended Soldering Footprint



Packing information

Package	Tape Width (mm)	Pitch		Reel Size		Per Reel Packing Quantity
		mm	inch	mm	inch	
TO-236	8	4 ± 0.1	0.157 ± 0.004	178	7	3,000

Marking information

- " VD " = Part No.
- " • " = HAF (Halogen and Antimony Free)
- " YM " = Date Code Marking
- " Y " = Year
- " M " = Month
- Font type: Arial

